

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/687,529	ABEL ET AL.	
Examiner	Art Unit	
S E E	1.00	

SEARCHED					
Class	Subclass	Date	Examiner		
435	4,14,25, 177,180, 287.1, 287.9	3/7/2005	SEF		
204	403.01	3/7/2005	SEF		
204	-403.14	3/7/2005	SEF		
600	347	3/7/2005	SEF		
	-				

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: US-PGPUB, USPAT, EPO, JPO, DERWENTsee search history	3/7/2005	SEF		
STN: CAPLUS, BIOSIS -see search query	3/7/2005	SEF		
Inventor name search performed using PALM and STN	3/7/2005	, SEF		
Consulted WO 02/083930 (PCT/CH02/00209), and PCT/CH02/00206	3/8/2005	SEF		
		=10		